

## SLOVENSKI STANDARD SIST EN 62769-103-1:2015

01-november-2015

Naprave in združevanje v proizvodne sisteme - Vključitev procesne naprave (FDI) - Profili - 103-1. del: PROFIBUS (IEC 62769-103-1:2015)

Devices and integration in enterprise systems; Field Device Integration (FDI) - Profiles - Part 103-1: PROFIBUS (IEC 62769-103-1:2015)

Feldgeräteintegration (FDI) - Profile - Teil 103-1: PROFIBUS (IEC 62769-103-1:2015)

## iTeh STANDARD PREVIEW

Intégration des appareils de terrain (FDI) a Partie 103-1: Profils - PROFIBUS (IEC 62769-103-1:2015)

SIST EN 62769-103-1:2015

Ta slovenski standard je istoveten z jalovsist EN 62769-103-1:2015

### ICS:

25.040.40 Merjenje in krmiljenje Industrial process industrijskih postopkov measurement and control
35.240.50 Uporabniške rešitve IT v IT applications in industry industriji

SIST EN 62769-103-1:2015 en,fr,de

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<u>SIST EN 62769-103-1:2015</u> https://standards.iteh.ai/catalog/standards/sist/48c58f0d-4d51-405b-b7d3-f405c77991a0/sist-en-62769-103-1-2015 EUROPEAN STANDARD NORME EUROPÉENNE EUROPÄISCHE NORM EN 62769-103-1

June 2015

ICS 25.040.40; 35.100

### **English Version**

# Field Device Integration (FDI) - Part 103-1: Profiles - PROFIBUS (IEC 62769-103-1:2015)

Intégration des appareils de terrain (FDI) - Partie 103-1: Profils - PROFIBUS (IEC 62769-103-1:2015) Feldgeräteintegration (FDI) - Profile - Teil 103-1: PROFIBUS (IEC 62769-103-1:2015)

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f405c77991a0/sist-en-62769-103-1-2015



European Committee for Electrotechnical Standardization Comité Européen de Normalisation Electrotechnique Europäisches Komitee für Elektrotechnische Normung

CEN-CENELEC Management Centre: Avenue Marnix 17, B-1000 Brussels

EN 62769-103-1:2015

### **European foreword**

The text of document 65E/354/CDV, future edition 1 of IEC 62769-103-1, prepared by SC 65E "Devices and integration in enterprise systems", of IEC/TC 65 "Industrial-process measurement, control and automation" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN 62769-103-1:2015.

The following dates are fixed:

- latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement
- latest date by which the national standards conflicting with (dow) 2018-06-16 the document have to be withdrawn

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## iTeh STANDARD PREVIEW

(stendorsement hotice)

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The text of the International Standard IEC 62769-103-1:2015 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following note has to be added for the standard indicated :

IEC 61804-3 NOTE Harmonized as EN 61804-3 (not modified).

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<sup>1)</sup> To be published.

EN 62769-103-1:2015

### Annex ZA

(normative)

# Normative references to international publications with their corresponding European publications

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 When an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: <a href="https://www.cenelec.eu">www.cenelec.eu</a>.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	EN/HD	<u>Year</u>
IEC 61784-1	-	Industrial communication networks - Profiles -	EN 61784-1	-
IEC 61804	series	Part 1; Fieldbus profiles Function blocks (FB) for process control - Electronic device description language (EDDL)	EN 61804	series
IEC 62541-100	2015 https://sta	OPC unified architecture 63-1:2015 nPart 100: Device Interfacest/48c58f0d-4d51-405	EN 62541-100 5b-b7d3-	2015
IEC 62769-2	-	Field Device Integration (FDI) 03-1-2015 Part 2: FDI Client	EN 62769-2 <sup>2)</sup>	-
IEC 62769-4	-	Field Device Integration (FDI) - Part 4: FDI Packages	EN 62769-4 <sup>2)</sup>	-
IEC 62769-5	-	Field Device Integration (FDI) - Part 5: FDI Information Model	EN 62769-5 <sup>2)</sup>	-
IEC 62769-7	-	Field Device Integration (FDI) - Part 7: FDI Communication Devices	EN 62769-7 <sup>2)</sup>	-

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<sup>2)</sup> To be published.

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# INTERNATIONAL STANDARD

# NORME INTERNATIONALE



Field device integration (FDI) ANDARD PREVIEW Part 103-1: Profiles – PROFIBUS dards.iteh.ai)

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

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#### INTERNATIONAL ELECTROTECHNICAL COMMISSION

### FIELD DEVICE INTEGRATION (FDI) -

Part 103-1: Profiles - PROFIBUS

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International Standard IEC 62769-103-1 has been prepared by subcommittee 65E: Devices and integration in enterprise systems, of IEC technical committee 65: Industrial-process measurement, control and automation.

The text of this standard is based on the following documents:

CDV	Report on voting
65E/354/CDV	65E/417/RVC

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 62769 series, published under the general title *Field Device Integration (FDI)*, can be found on the IEC website.

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The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

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#### INTRODUCTION

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The International Electrotechnical Commission (IEC) draws attention to the fact that it is claimed that compliance with this document may involve the use of patents concerning

- a) method for the supplying and installation of device-specific functionalities, see Patent Family DE10357276;
- b) method and device for accessing a functional module of automation system, see Patent Family EP2182418;
- c) methods and apparatus to reduce memory requirements for process control system software applications, see Patent Family US2013232186;
- d) extensible device object model, see Patent Family US12/893,680.

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